



P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)			
- 20	0.004 at V _{GS} = - 4.5 V	- 52 ^a	58 nC			
20	0.005 at V _{GS} = - 2.5 V	- 42 ^a	00110			

FEATURES

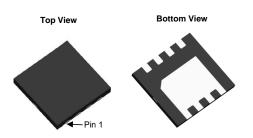
- Trench Power MOSFET
- Thermally Enhanced DFN3X3 Package
- Low On-Resistance for Low Voltage Drop



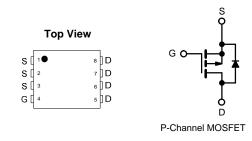
FREE

APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices



DFN 3x3 EP



ABSOLUTE MAXIMUM RATINGS	S (T _A = 25 °C, unle	ess otherwise no	oted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	V	
Gate-Source Voltage		V _{GS} ± 12		V	
Continuous Drain Current (T _J = 150 °C)	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	I _D	- 52 ^a - 40 ^a - 31 ^{b, c} - 25 ^{b, c}	A	
Pulsed Drain Current (t = 300 µs)		I _{DM}	- 208	1	
Continuous Source-Drain Diode Current	T _C = 25 °C T _A = 25 °C	I _S	- 52 ^a - 29 ^{b, c}	-	
Maximum Power Dissipation	$T_{C} = 25 \text{ °C}$ $T_{C} = 70 \text{ °C}$ $T_{A} = 25 \text{ °C}$ $T_{A} = 70 \text{ °C}$	P _D	89 33 6.5 ^{b, c} 4.2 ^{b, c}	W	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature	Ŭ	260			

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	18	26	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.3	1.5	0/11	

Notes:

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

- (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 80 °C/W.

d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper

SPECIFICATIONS ($T_J = 25 \degree C$				r]			
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 11		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			2.7			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	- 0.8		- 2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 12 V, V _{GS} = 0 V			- 1	- μΑ	
	'DSS				- 10		
On-State Drain Current ^a	I _{D(on)}	V_{DS} \leq - 5 V, V_{GS} = - 4.5 V	- 20			А	
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -5.3 \text{ A}$		0.004		Ω	
Drain Courses On State Desister and	Rea()	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -8.1 \text{ A}$		0.0045			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V_{GS} = - 2.5 V, I _D = - 5.3 A		0.005			
		$V_{GS} = -2.5 \text{ V}, I_D = -6 \text{ A}$		0.0054			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 18.5 A		94		S	
Dynamic ^b							
Input Capacitance	C _{iss}			4600		pF	
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		830			
Reverse Transfer Capacitance	C _{rss}			570			
		V _{DS} = - 6 V, V _{GS} = - 8 V, I _D = - 10 A		58 97		1	
Total Gate Charge	Qg			33	65	nC	
Gate-Source Charge	Q _{gs}	V _{DS} = - 6 V, V _{GS} = - 4.5 V, I _D = - 10 A		7			
Gate-Drain Charge	Q _{gd}			15.5			
Gate Resistance	R _g	f = 1 MHz		5		Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = - 6 V, R_L = 0.75 Ω		40	60	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8 Å, V_{GEN} = - 4.5 V, R_g = 1 Ω		65	100		
Fall Time	t _f			40	60		
Turn-On Delay Time	t _{d(on)}			10	15	- ns	
Rise Time	t _r	V_{DD} = - 6 V, R _L = 0.75 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8 A, V_{GEN} = - 8 V, R_g = 1 Ω		70	105		
Fall Time	t _f	-		40	60	1	
Drain-Source Body Diode Characterist			1			1	
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			- 52		
Pulse Diode Forward Current	I _{SM}				200	A	
Body Diode Voltage	V _{SD}	I _S = - 8 A, V _{GS} = 0 V		- 0.57	- 1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Diode Reverse Recovery Charge Q.			20	30	nC	
Reverse Recovery Fall Time	t _a	$I_F = -8 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		14			
Reverse Recovery Rise Time	t _b			26		ns	

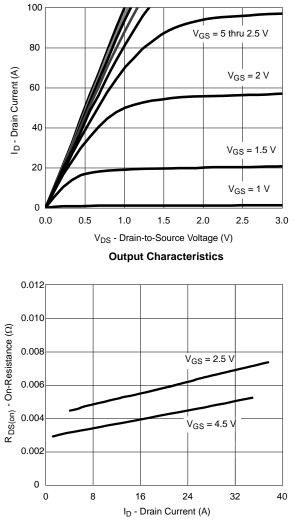
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

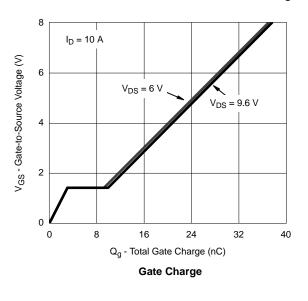
emi Bsemi.com

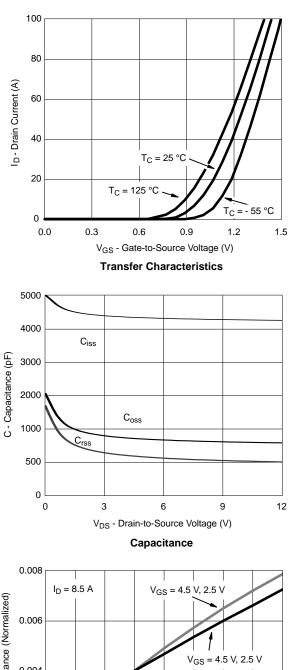


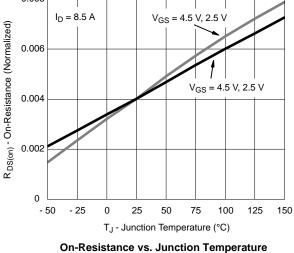


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

On-Resistance vs. Drain Current and Gate Voltage









T_A = 125 °C

T_A = 25 °C

4

5

2

1

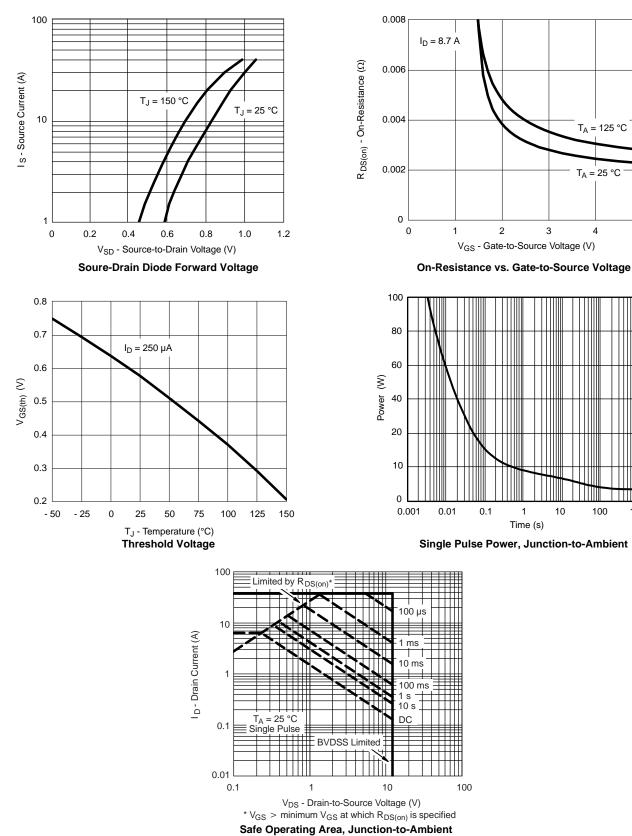
Time (s)

10

100

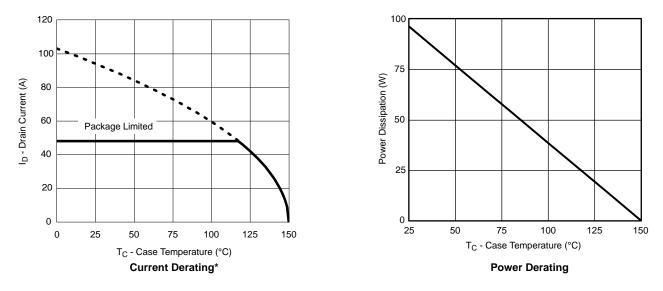
1000

3



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



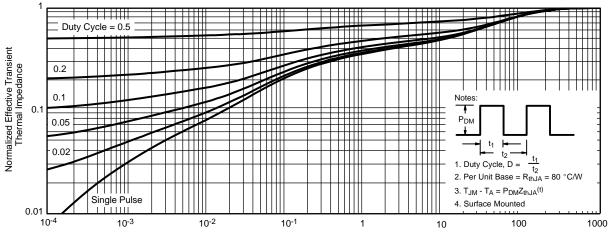


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

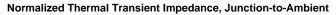
* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

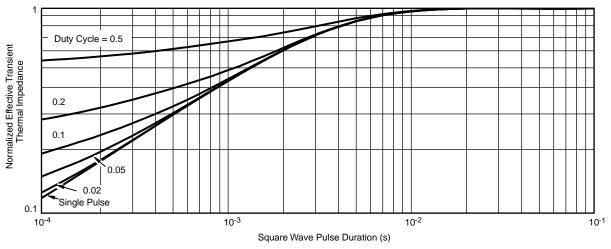


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Square Wave Pulse Duration (s)

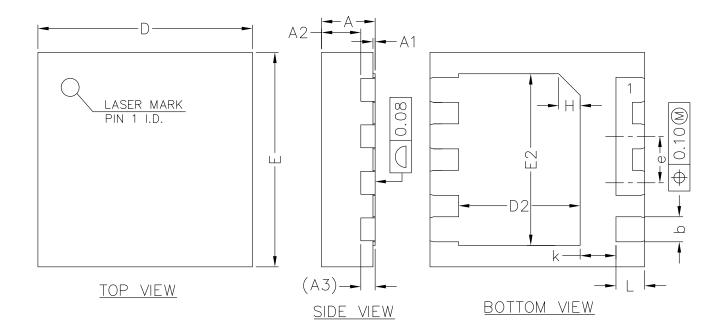




Normalized Thermal Transient Impedance, Junction-to-Case

VBQF2207

WBsemi www.VBsemi.com





<u>SIDE VIEW</u>

SYMBOL	MIN	NOM	MAX	
А	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A2	0.50	0.55	0.60	
A3	0.20REF			
b	0.30	0.35	0.40	
D	2.90	3.00	3.10	
E	2.90	3.00	3.10	
D2	1.60	1.70	1.80	
E2	2.30	2.40	2.50	
е	0.55	0.65	0.75	
К	0.40	0.50	0.60	
L	0.35	0.40	0.45	

COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)



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